

SN74ALS2240

OCTAL BUFFER AND LINE DRIVER/MOS DRIVER WITH 3-STATE OUTPUTS

SDAS268A – DECEMBER 1994 – REVISED NOVEMBER 1997

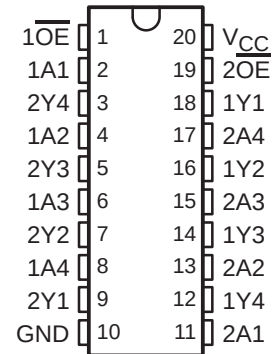
- Bidirectional Quadruple-Bus Transceivers for Driving MOS Devices
- I/O Ports Have 25-Ω Series Resistors, So No External Resistors Are Required
- Package Options Include Plastic Small-Outline (DW) Package and Standard Plastic (N) 300-mil DIPs

description

This octal buffer and line driver/MOS driver is designed to drive the capacitive inputs of MOS devices and to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device features high fan-out and improved fan-in.

The SN74ALS2240 is characterized for operation from 0°C to 70°C.

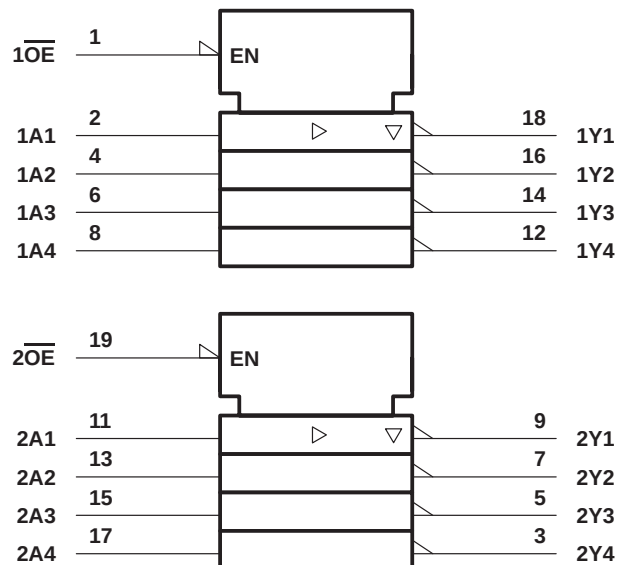
DW OR N PACKAGE
(TOP VIEW)



FUNCTION TABLE
(each buffer)

INPUTS		OUTPUT
OE	A	Y
L	H	L
L	L	H
H	X	Z

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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**TEXAS
INSTRUMENTS**

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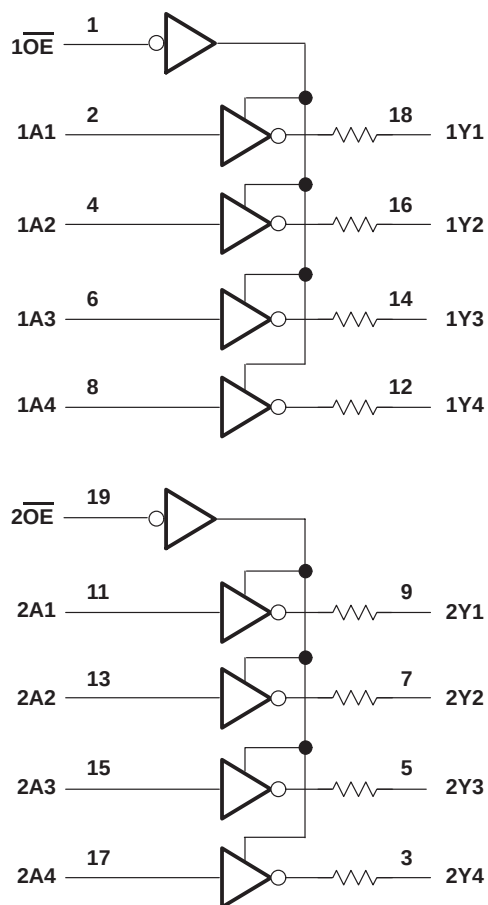
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logic diagram (positive logic)[†]



[†] All output resistors are 25 Ω .

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V_{CC}	7 V
Input voltage, V_I : All inputs	7 V
I/O ports	5.5 V
Operating free-air temperature range, T_A	0°C to 70°C
Storage temperature range, T_{stg}	–65°C to 70°C
Package thermal impedance, θ_{JA} (see Note 1): DW package	97°C/W
N package	67°C/W

[‡] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51, except for through hole packages, which use a trace length of zero.

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recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
T_A	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP [†]	MAX	UNIT
V_{IK}	$V_{CC} = 4.5\text{ V}$, $I_I = -18\text{ mA}$			-1.2	V
V_{OH}	$V_{CC} = 4.5\text{ V to } 5.5\text{ V}$, $I_{OH} = -0.4\text{ mA}$	$V_{CC} - 2$			V
V_{OL}	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 1\text{ mA}$	0.15	0.5	V
		$I_{OL} = 12\text{ mA}$	0.35	0.8	
I_{OZH}	$V_{CC} = 5.5\text{ V}$, $V_O = 2.7\text{ V}$			20	μA
I_{OZL}	$V_{CC} = 5.5\text{ V}$, $V_O = 0.4\text{ V}$			-20	μA
I_I	$V_{CC} = 5.5\text{ V}$, $V_I = 7\text{ V}$			0.1	mA
I_{IH}	$V_{CC} = 5.5\text{ V}$, $V_I = 2.7\text{ V}$			20	μA
I_{IL}	$V_{CC} = 5.5\text{ V}$, $V_I = 0.4\text{ V}$			-0.1	mA
$I_{O\ddagger}$	$V_{CC} = 5.5\text{ V}$, $V_O = 2.25\text{ V}$	-30		-112	mA
I_{OH}	$V_{CC} = 4.5\text{ V}$			-15	mA
I_{OL}	$V_{CC} = 4.5\text{ V}$			15	mA
I_{CC}	$V_{CC} = 5.5\text{ V}$	Outputs high	6	11	mA
		Outputs low	13	23	
		Outputs disabled	12	20	

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, I_{OS} .

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5\text{ V to } 5.5\text{ V}$, $C_L = 50\text{ pF}$, $R_1 = 500\ \Omega$, $R_2 = 500\ \Omega$, $T_A = \text{MIN to MAX}^\S$		UNIT
			MIN	MAX	
t_{PLH}	A	Y	2	10	ns
t_{PHL}			2	10	
t_{PZH}	$\overline{OE}$	Y	5	17	ns
t_{PZL}	$\overline{OE}$	Y	7	20	ns
t_{PHZ}	$\overline{OE}$	Y	2	10	ns
t_{PLZ}	$\overline{OE}$	Y	4	15	ns

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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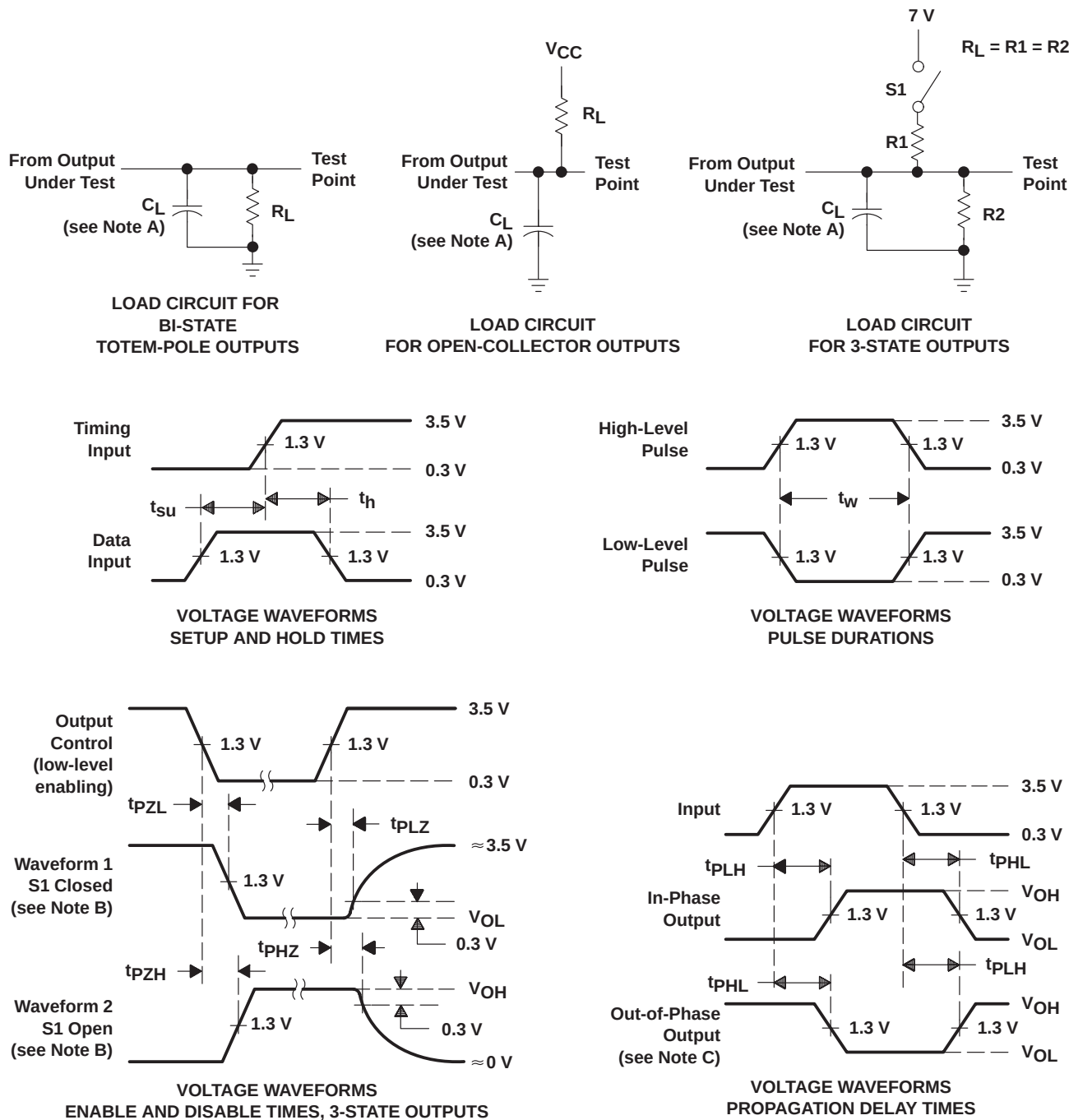
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PARAMETER MEASUREMENT INFORMATION

SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 D. All input pulses have the following characteristics: $PRR \leq 1$ MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
 E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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